

# TLE7183QU

3 Phase Driver IC

Automotive Power



Never stop thinking

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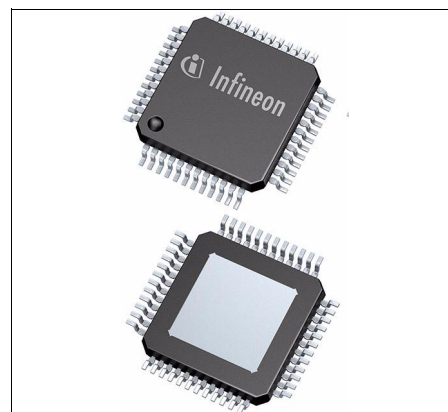
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## 1 Overview

### Features

- Compatible with very low ohmic normal level input N-Channel MOSFETs
- Separate input for each MOSFET
- PWM frequency up to 30kHz
- Fulfils specification down to 5.5V supply voltage
- Optimized Electromagnetic Compatibility (EMC)
- TQFP-48 package with exposed heat slug
- Control inputs with TTL characteristics
- Separate source connection for each MOSFET
- Integrated minimum dead time
- Shoot through protection
- Short circuit protection with 5 fixed detection levels available
- Disable and sleep mode features
- 2-bit error diagnosis
- Thermal overload warning for driver IC
- Integrated overcurrent warning
- Integrated current sense amplifier
- 0 to 100% duty cycle
- Green Product (RoHS compliant)
- AEC Qualified



**PG-TQFP-48**

### Description

The TLE7183QU driver IC is designed to control 6 to 12 external MOSFETs forming the converter for high current 3 phase motor drives in the automotive sector. It includes features like short circuit detection, 2-bit error diagnosis and high output performance. It meets the typical requirements of automotive applications, e.g. full functionality even at low battery voltages. Its 3 high side and 3 low side output stages are powerful enough to drive MOSFETs with a gate charge of 400 nC with rise and fall times of approximately 150 ns.

Typical applications are cooling fan, water pump, electro-hydraulic and electric power steering. The TLE7183QU is designed for a 12 V power net.

Several options are available for the fixed short circuit detection level.

| Option | Typ. SCD level | Marking        | Availability            |
|--------|----------------|----------------|-------------------------|
| SCD1   | 0.5V           | TLE7183QU SCD1 | please contact Infineon |
| SCD2   | 0.75V          | TLE7183QU SCD2 | available               |
| SCD3   | 1V             | TLE7183QU SCD3 | please contact Infineon |
| SCD4   | 1.5V           | TLE7183QU SCD4 | please contact Infineon |
| SCD5   | 2.0V           | TLE7183QU SCD5 | available               |

## 2 Block Diagram

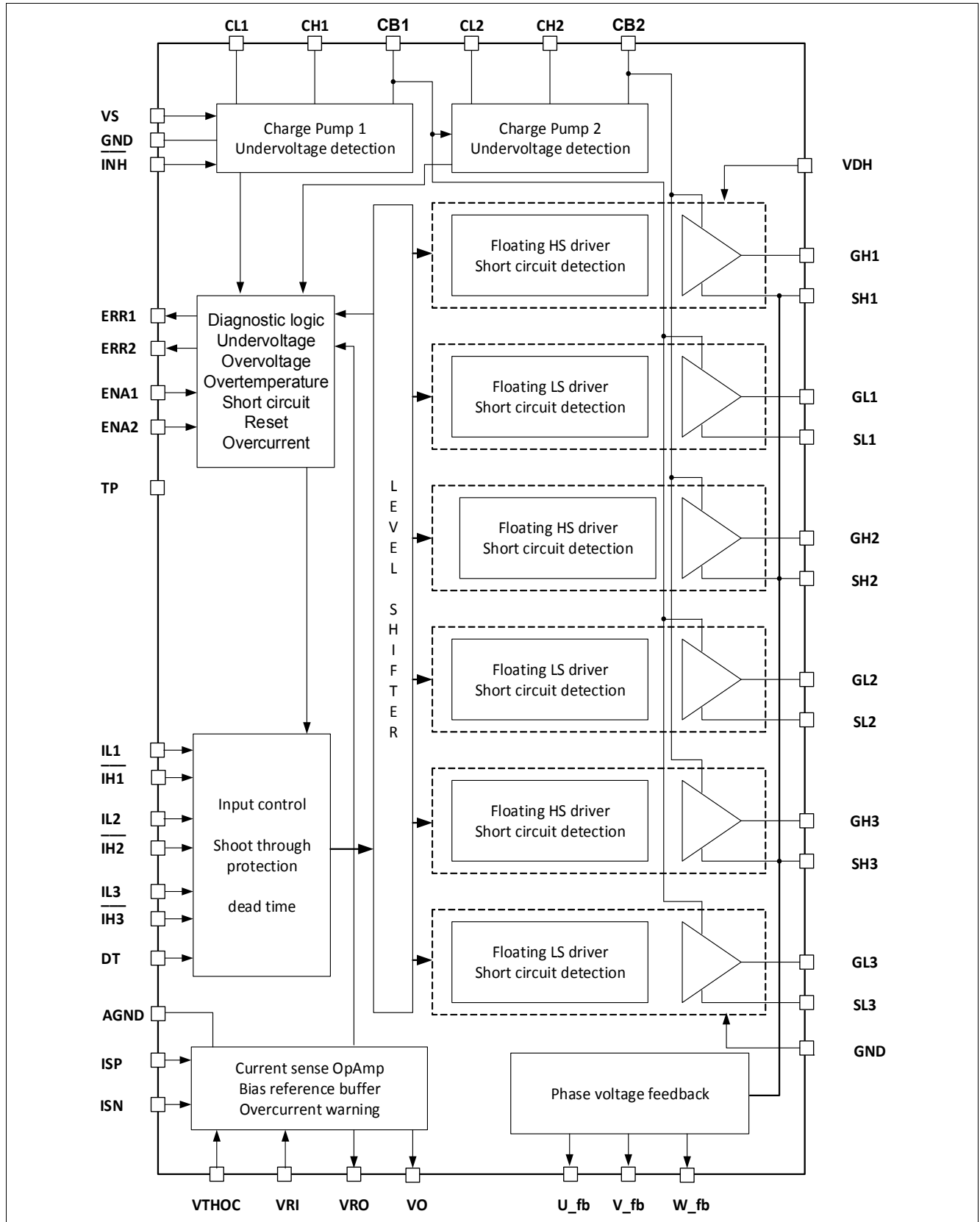
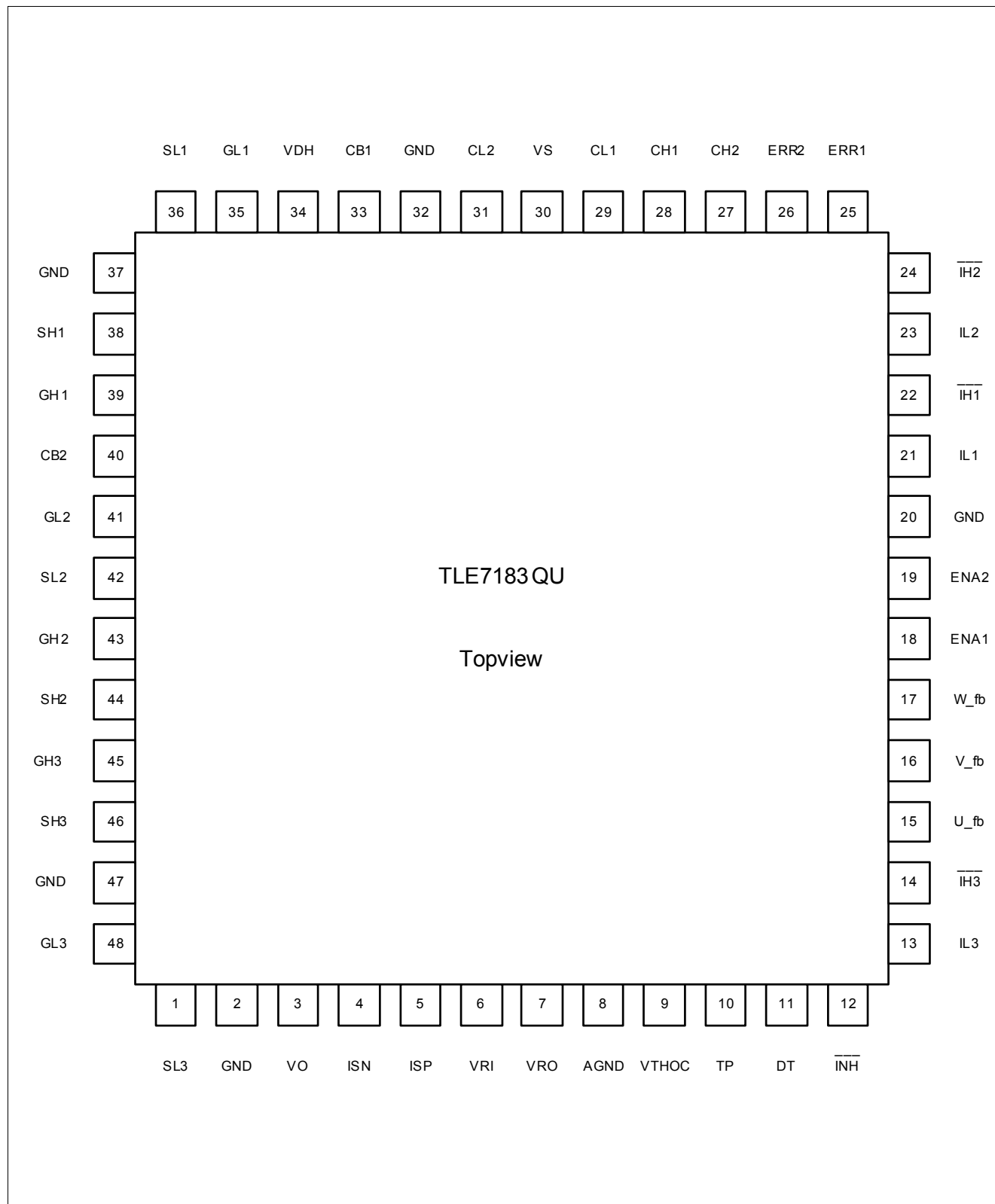


Figure 1 Block Diagram

### 3 Pin Configuration

#### 3.1 Pin Assignment TLE7183QU



**Figure 2 Pin Configuration**

### 3.2 Pin Definitions and Functions

| Pin | Symbol                  | Function                                                              |
|-----|-------------------------|-----------------------------------------------------------------------|
| 1   | SL3                     | Connection to source low side switch 3                                |
| 2   | GND                     | Logic and power ground                                                |
| 3   | VO                      | Output of OpAmp for shunt signal amplification                        |
| 4   | ISN                     | - Input of OpAmp for shunt signal amplification                       |
| 5   | ISP                     | + Input of OpAmp for shunt signal amplification                       |
| 6   | VRI                     | Input of bias reference amplifier                                     |
| 7   | VRO                     | Output of bias reference amplifier                                    |
| 8   | AGND                    | Analog ground especially for the current sense OpAmp                  |
| 9   | VTHOC                   | Threshold voltage for overcurrent detection                           |
| 10  | TP                      | test pin, connect to GND of driver IC                                 |
| 11  | DT                      | Dead time program pin                                                 |
| 12  | $\overline{\text{INH}}$ | Inhibit pin (active low)                                              |
| 13  | IL3                     | Input for low side switch 3 (active high)                             |
| 14  | $\overline{\text{IH3}}$ | Input for high side switch 3 (active low)                             |
| 15  | U_fb                    | Digital logic representation of the voltage phase U; positive logic   |
| 16  | V_fb                    | Digital logic representation of the voltage phase V; positive logic   |
| 17  | W_fb                    | Digital logic representation of the voltage phase W; positive logic   |
| 18  | ENA1                    | Enable pin (active high)                                              |
| 19  | ENA2                    | Enable pin (active high)                                              |
| 20  | GND                     | Logic and power ground                                                |
| 21  | IL1                     | Input for low side switch 1 (active high)                             |
| 22  | $\overline{\text{IH1}}$ | Input for high side switch 1 (active low)                             |
| 23  | IL2                     | Input for low side switch 2 (active high)                             |
| 24  | $\overline{\text{IH2}}$ | Input for high side switch 2 (active low)                             |
| 25  | ERR1                    | Error signal 1                                                        |
| 26  | ERR2                    | Error signal 2                                                        |
| 27  | CH2                     | + terminal for pump capacitor of charge pump 2                        |
| 28  | CH1                     | + terminal for pump capacitor of charge pump 1                        |
| 29  | CL1                     | - terminal for pump capacitor of charge pump 1                        |
| 30  | VS                      | Voltage supply                                                        |
| 31  | CL2                     | - terminal for pump capacitor of charge pump 2                        |
| 32  | GND                     | Logic and power ground                                                |
| 33  | CB1                     | Buffer capacitor for charge pump 1                                    |
| 34  | VDH                     | Connection to drain of high side switches for short circuit detection |
| 35  | GL1                     | Output to gate low side switch 1                                      |
| 36  | SL1                     | Connection to source low side switch 1                                |
| 37  | GND                     | Logic and power ground                                                |
| 38  | SH1                     | Connection to source high side switch 1                               |
| 39  | GH1                     | Output to gate high side switch 1                                     |
| 40  | CB2                     | Buffer capacitor for charge pump 2                                    |

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**Pin Configuration**

| Pin | Symbol | Function                                |
|-----|--------|-----------------------------------------|
| 41  | GL2    | Output to gate low side switch 2        |
| 42  | SL2    | Connection to source low side switch 2  |
| 43  | GH2    | Output to gate high side switch 2       |
| 44  | SH2    | Connection to source high side switch 2 |
| 45  | GH3    | Output to gate high side switch 3       |
| 46  | SH3    | Connection to source high side switch 3 |
| 47  | GND    | Logic and power ground                  |
| 48  | GL3    | Output to gate low side switch 3        |

## 4 General Product Characteristics

### 4.1 Absolute Maximum Ratings

#### Absolute Maximum Ratings <sup>1)</sup>

40 °C ≤ T<sub>j</sub> ≤ 150 °C; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.         | Parameter                                                      | Symbol      | Limit Values |      | Unit | Conditions                                                          |
|--------------|----------------------------------------------------------------|-------------|--------------|------|------|---------------------------------------------------------------------|
|              |                                                                |             | Min.         | Max. |      |                                                                     |
| Voltages     |                                                                |             |              |      |      |                                                                     |
| 4.1.1        | Supply voltage                                                 | $V_S$       | -4.0         | 45   | V    | with 10Ohm and 1μF                                                  |
| 4.1.2        | Supply voltage                                                 | $V_S$       | -0.3         | 45   | V    | –                                                                   |
| 4.1.3        | Supply voltage                                                 | $V_S$       | -0.3         | 47   | V    | $t_p$ <200ms                                                        |
| 4.1.4        | Voltage range at IHx, ILx, ERRx, VO, DT, VTHOC, ENAx, VRI, VRO | $V_{DP}$    | -0.3         | 6.0  | V    | –                                                                   |
| 4.1.5        | Voltage range at $\overline{INH}$                              | $V_{INH}$   | -0.3         | 18.0 | V    | –                                                                   |
| 4.1.6        | Voltage range at TP                                            | $V_{TP}$    | -0.3         | 2    | V    |                                                                     |
| 4.1.7        | Voltage range at SLx                                           | $V_{SL}$    | -7           | 7    | V    | –                                                                   |
| 4.1.8        | Voltage range at SHx                                           | $V_{SH}$    | -7           | 45   | V    | –                                                                   |
| 4.1.9        | Voltage range at GLx                                           | $V_{GL}$    | -7           | 18   | V    | –                                                                   |
| 4.1.10       | Voltage range at GHx                                           | $V_{GH}$    | -7           | 55   | V    | –                                                                   |
| 4.1.11       | Voltage difference Gxx-Sxx                                     | $V_{GS}$    | -0.3         | 15   | V    | –                                                                   |
| 4.1.12       | Voltage range at VDH                                           | $V_{VDH}$   | -0.3         | 55   | V    | $\overline{INH}$ =high                                              |
| 4.1.13       | Voltage range at VDH                                           | $V_{VDH}$   | -4.0         | 55   | V    | $\overline{INH}$ =high;<br>with $R_{VDH} > 70\Omega$ ;<br>200ms, 5x |
| 4.1.14       | Voltage range at VDH                                           | $V_{VDH}$   | -0.3         | 28   | V    | $\overline{INH}$ =low                                               |
| 4.1.15       | Voltage range at VDH                                           | $V_{VDH}$   | -4.0         | 28   | V    | $\overline{INH}$ =low;<br>with $R_{VDH} > 70\Omega$ ;<br>200ms, 5x  |
| 4.1.16       | Voltage range at CL1                                           | $V_{CL1}$   | -0.3         | 25   | V    | –                                                                   |
| 4.1.17       | Voltage range at CH1, CB1                                      | $V_{CH1}$   | -0.3         | 25   | V    | –                                                                   |
| 4.1.18       | Voltage difference CH1-CL1                                     | $V_{DC1}$   | -0.3         | 25   | V    | –                                                                   |
| 4.1.19       | Voltage range at CL2                                           | $V_{CL2}$   | -0.3         | 25   | V    | –                                                                   |
| 4.1.20       | Voltage range at CH2, CB2                                      | $V_{CH2}$   | -0.3         | 45   | V    | –                                                                   |
| 4.1.21       | Voltage difference CH2-CL2                                     | $V_{CP2}$   | -0.3         | 25   | V    | –                                                                   |
| 4.1.22       | Voltage range at ISP, ISN                                      | $V_{ISI}$   | -5           | 5    | V    | –                                                                   |
| 4.1.23       | Output current range at VO                                     | $I_{VO}$    | -20          | 20   | mA   | –                                                                   |
| 4.1.24       | Gate resistor                                                  | $R_{Gate}$  | 2            | –    | Ω    | –                                                                   |
| 4.1.25       | Voltage range at U_fb, V_fb and W_fb                           | $V_{X\_fb}$ | -0.3         | 6    | V    | –                                                                   |
| Temperatures |                                                                |             |              |      |      |                                                                     |
| 4.1.26       | Junction temperature                                           | $T_j$       | -40          | 150  | °C   | –                                                                   |
| 4.1.27       | Storage temperature                                            | $T_{sta}$   | -55          | 150  | °C   | –                                                                   |

## General Product Characteristics

**Absolute Maximum Ratings** (cont'd)<sup>1)</sup>
 $40^{\circ}\text{C} \leq T_j \leq 150^{\circ}\text{C}$ ; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                                       | Symbol           | Limit Values |      | Unit               | Conditions |
|--------|-------------------------------------------------|------------------|--------------|------|--------------------|------------|
|        |                                                 |                  | Min.         | Max. |                    |            |
| 4.1.28 | Lead soldering temperature<br>(1/16" from body) | $T_{\text{sol}}$ | —            | 260  | $^{\circ}\text{C}$ | —          |
| 4.1.29 | Peak reflow soldering temperature <sup>2)</sup> | $T_{\text{ref}}$ | —            | 260  | $^{\circ}\text{C}$ | —          |

**Thermal Resistance**

|        |                  |                   |   |   |     |   |
|--------|------------------|-------------------|---|---|-----|---|
| 4.1.30 | Junction to case | $R_{\text{thJC}}$ | — | 5 | K/W | — |
|--------|------------------|-------------------|---|---|-----|---|

**Power Dissipation**

|        |                                                                |                  |   |   |   |   |
|--------|----------------------------------------------------------------|------------------|---|---|---|---|
| 4.1.31 | Power Dissipation (DC) @ $T_{\text{CASE}}=125^{\circ}\text{C}$ | $P_{\text{tot}}$ | — | 2 | W | — |
|--------|----------------------------------------------------------------|------------------|---|---|---|---|

**ESD Susceptibility**

|        |                                                                        |                                               |      |     |    |                   |
|--------|------------------------------------------------------------------------|-----------------------------------------------|------|-----|----|-------------------|
| 4.1.32 | ESD Resistivity <sup>3)</sup>                                          | $V_{\text{ESD}}$                              | —    | 2   | kV |                   |
| 4.1.33 | ESD Resistivity to GND                                                 | $V_{\text{ESD}}$                              | -500 | 500 | V  | CDM <sup>4)</sup> |
| 4.1.34 | ESD Resistivity Pin 1, 12, 13, 24, 25, 36, 37, 48 (corner pins) to GND | $V_{\text{ESD1, 12, 13, 24, 25, 36, 37, 48}}$ | -750 | 750 | V  | CDM <sup>4)</sup> |

1) Not subject to production test, specified by design.

2) Reflow profile IPC/JEDEC J-STD-020C

3) ESD susceptibility HBM according to EIA/JESD 22-A 114B

4) ESD susceptibility, Charged Device Model "CDM" ESDA STM5.3.1

**Attention: Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.**

**Attention: Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.**

## 4.2 Functional Range

| Pos.  | Parameter                       | Symbol           | Limit Values |                          | Unit          | Conditions                                                                                                                                     |
|-------|---------------------------------|------------------|--------------|--------------------------|---------------|------------------------------------------------------------------------------------------------------------------------------------------------|
|       |                                 |                  | Min.         | Max.                     |               |                                                                                                                                                |
| 4.2.1 | Supply voltage <sup>1)2)</sup>  | $V_S$            | 5.5<br>5.5   | 20<br>28                 | V             | DC<br>$t < 1\text{s}$                                                                                                                          |
| 4.2.2 | Duty cycle <sup>3)</sup>        | D                | 0            | 100                      | %             | —                                                                                                                                              |
| 4.2.3 | PWM frequency                   | $f_{\text{PWM}}$ | 0            | 25                       | kHz           | Total gate charge<br>400nC                                                                                                                     |
| 4.2.4 | Quiescent current <sup>4)</sup> | $I_Q$            | —            | 30                       | $\mu\text{A}$ | $V_S, V_{\text{DH}} < 20\text{V}$                                                                                                              |
| 4.2.5 | Quiescent current into VDH      | $I_{Q\_VDH}$     | —            | 30                       | $\mu\text{A}$ | $V_{\text{DH}} < 20\text{V}$ ;<br>$V_S$ pin open                                                                                               |
| 4.2.6 | Supply current at $V_S$         | $I_{V_S}$        | —<br>—       | 175<br>175<br>110<br>110 | mA            | $f_{\text{PWM}}=25\text{kHz}$<br>$Q_G=250\text{nC}$ ;<br>$V_S = 5.5\text{V}$<br>$V_S = 14\text{V}$<br>$V_S = 17\text{V}$<br>$V_S = 20\text{V}$ |

## General Product Characteristics

| Pos.   | Parameter                                    | Symbol      | Limit Values |          | Unit | Conditions                      |
|--------|----------------------------------------------|-------------|--------------|----------|------|---------------------------------|
|        |                                              |             | Min.         | Max.     |      |                                 |
| 4.2.7  | Supply current at Vs(device disabled by ENA) | $I_{Vs(o)}$ | –            | 60<br>50 | mA   | Vs=5.5V..17V<br>Vs=17V..20V     |
| 4.2.8  | Current into VDH (device not in sleep mode)  | $I_{VDH}$   |              | 1.5      | mA   | $V_{VDH}$ =5.5..20V<br>INH=high |
| 4.2.9  | Voltage difference CB2-VDH                   | $V_{CB2}$   | -0.3         | 25       | V    | Operation mode                  |
| 4.2.10 | Junction temperature                         | $T_j$       | -40          | 150      | °C   |                                 |

1) max ratings for Tj has to be considered as well

2) For proper start up minimum Vs=6.5V is required

3) Duty cycle is referred to the high side input command ( $\overline{IHx}$ ); The duty cycles can be driven continuously and fully operational

4) total current consumption from power net (Vs and VDH)

*Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.*

### 4.3 Default State of Inputs

**Table 1 Default State of Inputs**

| Characteristic                                                    | State                                | Remark                       |
|-------------------------------------------------------------------|--------------------------------------|------------------------------|
| Default state of ILx (if ILx left open)                           | Low                                  | Low side MOSFETs off         |
| Default state of $\overline{IHx}$ (if $\overline{IHx}$ left open) | High                                 | High side MOSFETs off        |
| Default state of ENA (if ENA1 left open)                          | Low                                  | Device outputs disabled      |
| Default state of ENA (if ENA2 left open)                          | Low                                  | Device outputs disabled      |
| Default state of $\overline{INH}$ (if $\overline{INH}$ left open) | Low                                  | Sleep mode, $I_Q < 30 \mu A$ |
| Default State of sense amplifier output $V_O$ (ISP=ISN=0V)        | Zero ampere equivalent               | –                            |
| Status of the device and the outputs when ENA1=ENA2=INH=high      | Device active and outputs functional | Vs=5.5..28V                  |
| Pull up or pull down integrated resistors Ixx, ENA                | 30k $\Omega$ +/-50%                  | –                            |
| Pull down integrated resistor $\overline{INH}$                    | 45k $\Omega$ +/-50%                  | –                            |

*Note: The load condition “C=22nF;  $R_{Load}$ =1 $\Omega$ ” in the paragraph “Electrical characteristics / Dynamic charactersitic” means that  $R_{Load}$  is connected between the output Gxx and the positive terminal of the C. The negative terminal of the C is connected to GND and the corresponding Sxx. The voltage is measured at the positive terminal of the C.*

## 5 Description and Electrical Characteristics

### 5.1 MOSFET Driver

#### 5.1.1 Output Stages

The six powerful push-pull output stages of the TLE7183QU are floating blocks, each one of them with its own source pin which can be directly connected to the source pin of an external MOSFET. This enables a perfect control of each MOSFET's gate-source voltage even if a current of 200A is driven in the bridge.

All output stages have the same high output power. A single output stage is able to drive a single MOSFET with 400nC gate charge (or two MOSFETs with 200nC) achieving rise and fall times of approx. 150ns.

They can be switched with a frequency of up to 30kHz. The usability at higher frequencies is limited by the maximum allowed power dissipation, the max. junction temperature and the limited current capabilities of the charge pump.

Each output stage has its own short circuit detection block. Please see [Chapter 5.2.1](#) for short circuit detection details.

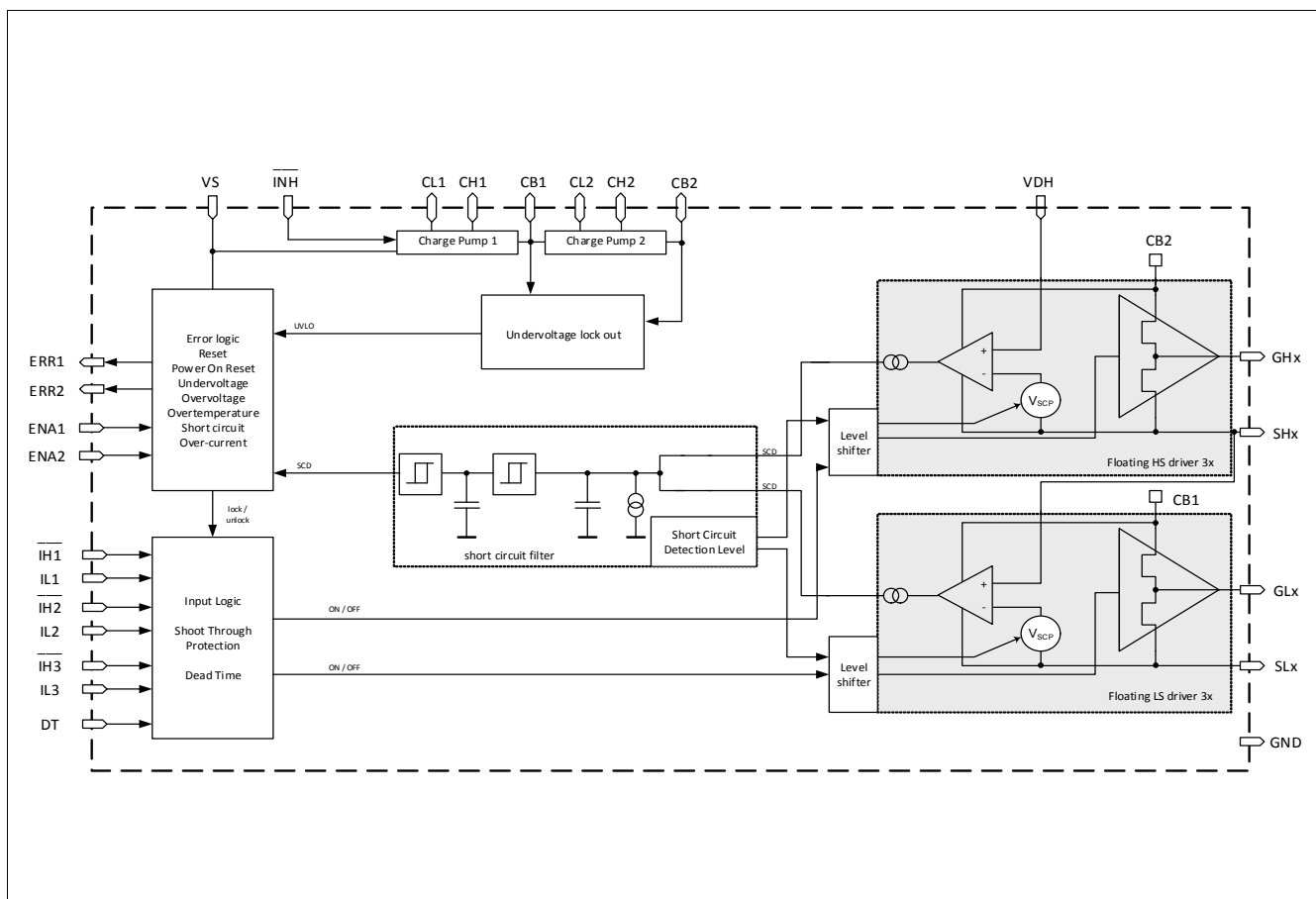


Figure 3 Block Diagram of Driver Output Stages including Short Circuit Detection

### 5.1.2 Operation at $V_s < 12V$ - Integrated Charge Pumps

In 12V automotive applications, correct operation has to be assured also at lower supply voltages, even at 9V. At low supply voltages conventional bridge drivers provide clearly less than 9V to the gate of an external MOSFET. However low gate-source voltage increases  $R_{DSon}$  of the MOSFET. This leads to an undesired, higher power dissipation.

The two charge pumps circuitries of TLE7183QU address this problem enabling operation even at lower supply voltages. Their operational capability does not depend on a specific pulse pattern of the MOSFETs overcoming duty cycle limitations which are inherent to drivers that use the bootstrap principle instead. Therefore TLE7183QU supports the complete duty cycle range from 0 to 100%. This simplifies the usability in all applications and especially when used with block wise commutation. The charge pumps are only deactivated if the device is set to sleep mode using  $\overline{INH}$ .

The first charge pump supplies the low side MOSFETs and the corresponding output stages with sufficient voltage to assure 10V gate-source voltage even if  $V_s < 10V$ . In addition it also supplies most of the internal circuitries, including the second charge pump.

The second charge pump supplies the high side MOSFETs and the corresponding output stages. It is pumped on the voltage of  $V_s$ .

Each charge pump circuitry requires external pump (CPx) and buffer (CBx) capacitors. The output of the first charge pump is CB1 which is referenced to GND. The output of the second charge pump is CB2 which is referenced to VDH. VDH and  $V_s$  are usually in the same voltage range. The driver is not designed to have significant higher voltages at VDH compared to  $V_s$ . This would lead to reduced supply voltages for the high side output stages.

The outputs of both charge pumps are regulated. The first charge pump doubles the supply voltage for  $V_s < 8V$ . For  $8V < V_s < 15V$ , its output is regulated to a typical voltage of 15V. For  $V_s > 15V$ , its output increases linearly but does not exceed 25V.

For a proper wake up of the device at  $V_{VSWU}$ , it is not permitted to have any PWM patterns at the input pins ILx and IHx before the charge pumps have ramped up to their final values unless the output stages have been switched off by setting one of the ENAx pins to low.

The size of the charge pump capacitors (pump capacitors CPx as well as buffer capacitors CBx) can be varied between 1  $\mu F$  and 4.7  $\mu F$ . Yet, larger capacitor values result in higher charge pump voltages and less voltage ripple on the charge pump buffer capacitors CBx (which supply the internal circuits as well as the external MOSFETs, pls. see above). Besides the capacitance values the ESR of the buffer capacitors CBx determines the voltage ripple as well. It is recommended to use buffer capacitors CBx that have small ESR.

Please see also [Chapter 5.1.3](#) for capacitor selection.

### 5.1.3 Sleep Mode

If the  $\overline{INH}$  pin is set to low, the driver will be set to sleep mode. The  $\overline{INH}$  pin switches off the complete supply structure of the device and finally leads to an undervoltage shut down of the complete driver. Enabling the device with the  $\overline{INH}$  pin means to switch on the supply structure. The device will run through power on reset during wake up. It is recommended to perform a reset using ENAx after wake up to remove possible ERRx signals. Reset is performed by keeping one or more ENAx pins low until the charge pump voltages have ramped up.

Enabling and disabling with the  $\overline{INH}$  pin is not very fast. Please consider using the ENAx pins to speed things up.

If the TLE7183QU is in sleep mode or if the supply voltage  $V_s$  is not available, then the driver IC is not supplied, the charge pumps are inactive and the charge pump capacitors are discharged. Pin CB2 (+ terminal of buffer capacitor 2) will decay to GND. If the battery voltage is still applied to VDH (- terminal of buffer capacitor 2) the buffer capacitor 2 will slowly be charged to battery voltage with reversed polarity compared to the one during regular operation. Hence, it is important to use a buffer capacitor 2 (CB2) that can withstand both, +25 V in regular operation mode and  $-V_{BAT}$  in sleep mode, e.g. a ceramic capacitor. If there is load dump in sleep mode, then the negative voltage across CB2 will be clamped to -31 V (CB2 referenced to VDH).

## 5.1.4 Electrical Characteristics

### Electrical Characteristics MOSFET drivers - DC Characteristics

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ ,  $f_{PWM} < 25kHz$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                                                                                               | Symbol       | Limit Values |      |                   | Unit | Conditions                                                                                   |
|--------|---------------------------------------------------------------------------------------------------------|--------------|--------------|------|-------------------|------|----------------------------------------------------------------------------------------------|
|        |                                                                                                         |              | Min.         | Typ. | Max.              |      |                                                                                              |
| 5.1.1  | Low Level Output Voltage                                                                                | $V_{G\_LL}$  | –            | –    | 0.2               | V    | $I = 30mA$                                                                                   |
| 5.1.2  | High Level Output Voltage, Low Side                                                                     | $V_{G\_HL}$  | 7.5          | –    | 13                | V    | $I = -2mA$ ; $V_S = 5.5..8V$                                                                 |
| 5.1.3  | High Level Output Voltage, High Side                                                                    | $V_{G\_HL}$  | 6.5          | –    | 13                | V    | $I = -2mA$ ; $V_S = 5.5..8V$                                                                 |
| 5.1.4  | High Level Output Voltage                                                                               | $V_{G\_HL}$  | 9            | –    | 13                | V    | $I = -2mA$ ; $V_S = 8..20V$                                                                  |
| 5.1.5  | High Level Output Voltage Difference                                                                    | $dV_{G\_H}$  | –            | –    | 1.0               | V    | $I = -100mA$ ; $V_S = 20V$                                                                   |
| 5.1.6  | Gate Drive Output Voltage (device disabled via ENAx)                                                    | $V_{G(DIS)}$ | –            | –    | 0.2               | V    | Disabled;<br>$V_S = 5.5..20V$ ;<br>$I = 10mA$                                                |
| 5.1.7  | Gate Drive Output Voltage<br>$T_j = -40^\circ C$<br>$T_j = 25^\circ C$<br>$T_j = 150^\circ C$           | $V_{G\_5}$   | –            | –    | 1.4<br>1.2<br>1.0 | V    | UVLO; $V_S \leq 5.5V$                                                                        |
| 5.1.8  | Gate Drive Output Voltage High Side<br>$T_j = -40^\circ C$<br>$T_j = 25^\circ C$<br>$T_j = 150^\circ C$ | $V_{G\_HS}$  | –            | –    | 1.4<br>1.2<br>1.0 | V    | Overvoltage                                                                                  |
| 5.1.9  | Gate Drive Output Voltage Low Side                                                                      | $V_{G\_LS}$  | –            | –    | 0.2               | V    | Overvoltage                                                                                  |
| 5.1.10 | Low Level Input Voltage of Ixx, ENAx                                                                    | $V_{I\_LL}$  | –            | –    | 1.0               | V    | –                                                                                            |
| 5.1.11 | High Level Input Voltage of Ixx, ENAx                                                                   | $V_{I\_HL}$  | 2.0          | –    | –                 | V    | –                                                                                            |
| 5.1.12 | Low Level Input Voltage of $\overline{INH}$                                                             | $V_{I\_LL}$  | –            | –    | 0.75              | V    | –                                                                                            |
| 5.1.13 | High Level Input Voltage of $\overline{INH}$                                                            | $V_{I\_HL}$  | 2.1          | –    | –                 | V    | –                                                                                            |
| 5.1.14 | Input Hysteresis of $\overline{IHx}$ , $\overline{ILx}$ , ENAx                                          | $dV_I$       | 50           | –    | –                 | mV   | $V_S = 5.5..8V$                                                                              |
| 5.1.15 | Input Hysteresis of $\overline{IHx}$ , $\overline{ILx}$ , ENAx                                          | $dV_I$       | 100          | 200  | –                 | mV   | $V_S = 8..20V$                                                                               |
| 5.1.16 | Output Bias Current SHx                                                                                 | $I_{SHx}$    | -1.6         | -1.0 | -0.3              | mA   | $V_{SHx} = 0..(V_S + 1)$ ;<br>$\overline{ILx} = \text{low}$ ; $\overline{IHx} = \text{high}$ |
| 5.1.17 | Output Bias Current SLx                                                                                 | $I_{SLx}$    | -1.6         | -1.0 | -0.3              | mA   | $V_{SLx} = 0..7V$ ;<br>$\overline{ILx} = \text{low}$ ; $\overline{IHx} = \text{high}$        |

## Description and Electrical Characteristics

**Electrical Characteristics MOSFET drivers - Dynamic Characteristics**

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ ,  $f_{PWM} < 25kHz$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                                                                              | Symbol         | Limit Values                 |                              |                              | Unit    | Conditions                                                                                                              |
|--------|----------------------------------------------------------------------------------------|----------------|------------------------------|------------------------------|------------------------------|---------|-------------------------------------------------------------------------------------------------------------------------|
|        |                                                                                        |                | Min.                         | Typ.                         | Max.                         |         |                                                                                                                         |
| 5.1.18 | Minimum Internal Dead Time                                                             | $t_{DT\_MIN}$  | 50                           | –                            | 200                          | ns      | DT pin to GND ( $R_{DT}=0\Omega$ )                                                                                      |
| 5.1.19 | Programmable Internal Dead Time                                                        | $t_{DT}$       | 0.26<br>0.64<br>1.07<br>2.02 | 0.41<br>1.05<br>1.85<br>3.82 | 0.56<br>1.45<br>2.63<br>5.62 | $\mu s$ | $R_{DT}=10\text{ k}\Omega$<br>$R_{DT}=47\text{ k}\Omega$<br>$R_{DT}=100\text{ k}\Omega$<br>$R_{DT}=1000\text{ k}\Omega$ |
| 5.1.20 | Maximum Internal Dead Time                                                             | $t_{DT\_MAX}$  | 2.33                         | –                            | 6.35                         | $\mu s$ | DT pin open                                                                                                             |
| 5.1.21 | Turn On Current, Peak                                                                  | $I_{G(on)}$    | –                            | -0.8                         | –                            | A       | $V_{Gxx}-V_{Sxx}=0V$ ;<br>$V_S=5.5..8V$ ;<br>$C=22nF$ ;<br>$R_{Load}=1\Omega$                                           |
| 5.1.22 | Turn On Current, Peak                                                                  | $I_{G(on)}$    | –                            | -1.5                         | –                            | A       | $V_{Gxx}-V_{Sxx}=0V$ ;<br>$V_S=8..20V$<br>$C=22nF$ ;<br>$R_{Load}=1\Omega$                                              |
| 5.1.23 | Turn Off current, Peak                                                                 | $I_{G(off)}$   | –                            | 1.5                          | –                            | A       | $V_{Gxx}-V_{Sxx}=10V$ ;<br>$V_S=8..20V$<br>$C=22nF$ ;<br>$R_{Load}=1\Omega$                                             |
| 5.1.24 | Rise Time (20-80%)<br>$T_j = -40^\circ C$<br>$T_j = 25^\circ C$<br>$T_j = 150^\circ C$ | $t_{G\_rise}$  | –                            | 150                          | 400<br>400<br>700            | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.25 | Fall Time (20-80%)<br>$T_j = -40^\circ C$<br>$T_j = 25^\circ C$<br>$T_j = 150^\circ C$ | $t_{G\_fall}$  | –                            | 150                          | 230<br>230<br>500            | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.26 | Input Propagation Time (Low on)                                                        | $t_{P(ILN)}$   | 90                           | 190                          | 290                          | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.27 | Input Propagation Time (Low off)                                                       | $t_{P(ILF)}$   | 0                            | 100                          | 200                          | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.28 | Input Propagation Time (High on)                                                       | $t_{P(IHN)}$   | 90                           | 190                          | 290                          | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.29 | Input Propagation Time (High off)                                                      | $t_{P(IHF)}$   | 0                            | 100                          | 200                          | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.30 | Absolute Input Propagation Time Difference (all channels turn on)                      | $t_{P(an)}$    | –                            | –                            | 70                           | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.31 | Absolute Input Propagation Time Difference (all channels turn off)                     | $t_{P(af)}$    | –                            | –                            | 50                           | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.32 | Absolute Input Propagation Time Difference (1channel High off - Low on)                | $t_{P(1hfin)}$ | –                            | –                            | 150                          | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |
| 5.1.33 | Absolute Input Propagation Time Difference (1channel Low off - High on)                | $t_{P(1hfn)}$  | –                            | –                            | 150                          | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                                                           |

## Description and Electrical Characteristics

**Electrical Characteristics MOSFET drivers - Dynamic Characteristics**

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ ,  $f_{PWM} < 25kHz$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                                                                   | Symbol           | Limit Values |      |      | Unit    | Conditions                                                                              |
|--------|-----------------------------------------------------------------------------|------------------|--------------|------|------|---------|-----------------------------------------------------------------------------------------|
|        |                                                                             |                  | Min.         | Typ. | Max. |         |                                                                                         |
| 5.1.34 | Absolute Input Propagation Time Difference (all channels High off - Low on) | $t_{P(ahfln)}$   | –            | –    | 150  | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                           |
| 5.1.35 | Absolute Input Propagation Time Difference (all channels Low off - High on) | $t_{P(alhfn)}$   | –            | –    | 150  | ns      | $C=22nF$ ; $R_{Load}=1\Omega$                                                           |
| 5.1.36 | Wake Up Time; $\overline{INH}$ Low to High                                  | $t_{INH\_Pen}$   | –            | –    | 20   | ms      | Driver fully functional;<br>$V_S=6.5\dots 8V$ ;<br>$ENAx=low$ ;<br>$CPx=CBx=4.7\mu F$   |
| 5.1.37 | Wake Up Time; $\overline{INH}$ Low to High                                  | $t_{INH\_Pen}$   | –            | –    | 10   | ms      | Driver fully functional;<br>$V_S=8\dots 20V$ ;<br>$ENAx=low$ ;<br>$CPx=CBx=4.7\mu F$ ;  |
| 5.1.38 | Wake Up Time Logic Functions; $\overline{INH}$ Low to High                  | $t_{INH\_log}$   | –            | –    | 10   | ms      | diagnostic, OpAmp working;<br>$V_S=6.5\dots 8V$ ;<br>$ENAx=low$ ;<br>$CPx=CBx=4.7\mu F$ |
| 5.1.39 | Wake Up Time Logic Functions; $\overline{INH}$ Low to High                  | $t_{INH\_log}$   | –            | –    | 5    | ms      | diagnostic, OpAmp working;<br>$V_S=8\dots 20V$ ;<br>$ENAx=low$ ;<br>$CPx=CBx=4.7\mu F$  |
| 5.1.40 | $\overline{INH}$ Propagation Time to Disable the Output Stages              | $t_{INH\_P(O)}$  | –            | –    | 10   | $\mu s$ | $V_S=5.5\dots 8V$                                                                       |
| 5.1.41 | $\overline{INH}$ Propagation Time to Disable the Output Stages              | $t_{INH\_P(O)}$  | –            | –    | 8    | $\mu s$ | $V_S=8\dots 20V$                                                                        |
| 5.1.42 | $\overline{INH}$ Propagation Time to Disable the entire Driver IC           | $t_{INH\_P(IC)}$ | –            | –    | 300  | $\mu s$ | –                                                                                       |
| 5.1.43 | Supply Voltage $V_S$ for Wake Up                                            | $V_{VSWU}$       | 6.5          | –    | –    | V       | diagnostic, OpAmp working;                                                              |
| 5.1.44 | Charge Pump Frequency                                                       | $f_{CP}$         | 38           | 55   | 72   | kHz     | –                                                                                       |

## 5.2 Protection and Diagnostic Functions

### 5.2.1 Short Circuit Detection

The TLE7183QU provides a short circuit detection for the external MOSFETs. It monitors their drain-source voltage. It is active as soon as the corresponding input is set to "on" and the dead time has elapsed.

If the drain-source voltage is higher than the short circuit detection level, a timer will be started. After a delay of about 6  $\mu$ s all external MOSFETs will be switched off. The ERRx pins will indicate a short circuit. This error is not self-clearing. The driver has to be reset using one of the ENAx pins.

The short circuit detection level is a fixed setting of the chip. Several options are available and described in [Chapter 5.2.8](#).

### 5.2.2 Overcurrent Warning

The TLE7183QU offers the possibility to have a warning at the ERRx pins if a current threshold is reached. (see [Figure 4](#) ).

The output of the current sense OpAmp is connected to an integrated comparator. It compares the amplified current sense signal with an external adjustable threshold. After the comparator a blanking time (1.5  $\mu$ s typ.) is implemented to avoid false triggering caused by an overshoot of the current sense signal. If the overcurrent situation is detected, there is a warning at the ERRx pins.

The driver remains in normal operation mode. The overcurrent warning is self-clearing. It will be cleared if the current drops below the overcurrent limit set on the VTHOC pin. The overcurrent warning is also cleared if the current commutates from the low side MOSFET to the associated high side MOSFET (no current through the shunt resistor).

It is up to the user to react on the overcurrent warning by modifying the Ixx patterns to lower the current.

### 5.2.3 Dead Time and Shoot Through Protection

In bridge applications it has to be assured that the external high side and low side MOSFETs in a single half bridge are not switched on at the same time. This would lead to a direct connection from battery voltage to GND. The integrated mechanisms of TLE7183QU preventing this are called shoot through protection and minimum dead time generation.

The shoot through protection is a locking mechanism which deals with faulty input commands at the Ixx pins. If the command is given to switch on the high side and the low side MOSFET of a single half bridge at same time, it is ignored. The driver output stages remain unchanged.

The dead time of a half bridge is the time after the command to switch off a MOSFET has been given during which the command to switch on the other MOSFET is not executed. A minimum dead time has to be applied because switching does not happen instantly. If both MOSFETs of a single half bridge start to switch at the same time, both of them may be on at the same time causing the critical connection from battery voltage to ground. The dead time assures that a MOSFET is only switched on after the other one has been switched off.

The exact dead time of the bridge is usually set by the PWM generation unit of the  $\mu$ C. The minimum dead time generation of TLE7183QU assures a minimum dead time if the input signals from the  $\mu$ C are faulty. If the DT pin is connected to GND, the generated minimum dead time is fixed to 50..200ns .

It can be increased by connecting the DT pin via a dead time resistor  $R_{DT}$  to GND - the larger the dead time resistor, the larger the dead time (please see [Programmable Internal Dead Time](#) for details).

### 5.2.4 Undervoltage Shut Down

The TLE7183QU has an integrated undervoltage shut down, to assure that the behavior of the device is predictable in all supply voltage ranges.

If the voltage of a charge pump buffer capacitors CBx reaches the undervoltage shut down level for a minimum specified filter time, the gate-source voltage of all external MOSFETs will be actively pulled to low. In this situation the short circuit detection of this output stage is deactivated to avoid a latching shut down of the driver.

If the charge pump buffer voltage recovers, the status of the output stages will match the input patterns again. This allows an operation of the motor in case of undervoltage shut down without a reset by the  $\mu\text{C}$ .

Undervoltage shut down will not occur if  $V_S > 6\text{ V}$ ,  $Q_G < 250\text{ nC}$ ,  $f_{\text{PWM}} < 25\text{ kHz}$ , and the charge pump capacitors CPx, CBx = 4.7  $\mu\text{F}$ .

## 5.2.5 Overvoltage Shutdown

The TLE7183QU has an integrated overvoltage shut down to avoid destruction of the IC at high supply voltages. The voltages at the pins Vs and VDH are monitored. The external MOSFETs will be switched off if one or both of them exceed the overvoltage shut down level for more than the specified filter time. In addition, the overvoltage condition will lead to a shut down of the charge pumps and a discharge of the charge pump capacitors. This results in an undervoltage condition which will be indicated at the ERRx pins. During overvoltage shut down the external MOSFETs and the charge pumps remain off until a reset is performed.

## 5.2.6 Overtemperature Warning

If the junction temperature is exceeding typ. 170°C, an overtemperature warning is reported at the ERRx pins. However the driver IC will continue to operate in order not to disturb the application.

This warning is self-clearing and will be cleared if the junction temperature cools down again. It is up to the user to protect the device from overtemperature destruction.

## 5.2.7 ERRx pins

The TLE7183QU has two status pins to provide diagnostic feedback to a  $\mu\text{C}$ . The outputs of these pins are 5V push pull stages which are either high or low. [Table 2](#) contains an overview. Some errors require a full reset of the driver using one of the ENAx pins to return to normal operation. Please see [Table 3](#) for details.

If multiple errors occur at the same time, only the one with the highest priority listed in [Table 4](#) is reported. If the device is disabled using one of the ENAx pins, only the errors Undervoltage and Overtemperature Warning are reported. Other errors are not reported.

**Table 2 Overview of Error Conditions**

| ERR1 | ERR2 | Driver conditions                                |
|------|------|--------------------------------------------------|
| Low  | Low  | no errors                                        |
| High | Low  | Overtemperature Warning or Overvoltage Shut Down |
| High | High | Undervoltage Shut Down                           |
| Low  | High | Short Circuit Detection or Overcurrent Warning   |

**Table 3 Behavior at different Error Conditions**

| Error condition         | restart behavior                           | Shuts down...               |
|-------------------------|--------------------------------------------|-----------------------------|
| Short Circuit Detection | Latch, reset must be performed at ENAx pin | All external Power -MOSFETs |
| Overcurrent Warning     | Self clearing                              | Nothing                     |
| Undervoltage Shut Down  | Auto restart                               | All external Power -MOSFETs |
| Overvoltage Shut Down   | Latch, reset must be performed at ENAx pin | All external Power -MOSFETs |
| Overtemperature Warning | Self clearing                              | Nothing                     |

*Note: Errors do NOT lead to sleep mode. Sleep mode is only initiated with the  $\overline{\text{INH}}$  pin. The latch and restart behavior allows to distinguish between the different combined error types reported at the ERRx pins.*

**Table 4 Prioritization of Errors**

| Priority | Error                                          |
|----------|------------------------------------------------|
| 1        | Short Circuit Detection                        |
| 2        | Undervoltage Shut Down                         |
| 3        | Overvoltage Shut Down                          |
| 4        | Overtemperature Warning<br>Overcurrent Warning |

## 5.2.8 Electrical Characteristics

### Electrical Characteristics - Protection and diagnostic functions

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.                     | Parameter                                                       | Symbol          | Limit Values |      |      | Unit | Conditions                                                                             |
|--------------------------|-----------------------------------------------------------------|-----------------|--------------|------|------|------|----------------------------------------------------------------------------------------|
|                          |                                                                 |                 | Min.         | Typ. | Max. |      |                                                                                        |
| Overtemperature          |                                                                 |                 |              |      |      |      |                                                                                        |
| 5.2.1                    | Overtemperature Warning                                         | $T_{j(OW)}$     | 150          | 170  | 190  | °C   | –                                                                                      |
| 5.2.2                    | Hysteresis for Overtemperature Warning                          | $dT_{j(OW)}$    | –            | 20   | –    | °C   | –                                                                                      |
| Overcurrent warning      |                                                                 |                 |              |      |      |      |                                                                                        |
| 5.2.3                    | Overcurrent Threshold                                           | $V_{THOC}$      | 2            | –    | 4.5  | V    | Vs=5.5..8V                                                                             |
| 5.2.4                    | Overcurrent Threshold                                           | $V_{THOC}$      | 2            | –    | 4.8  | V    | Vs=8..20V                                                                              |
| 5.2.5                    | Input Offset Voltage of OC Comp                                 | $V_{OCO F}$     | -50          | –    | 50   | mV   | –                                                                                      |
| 5.2.6                    | Input Offset Voltage Temperature Drift of OC Comp <sup>1)</sup> | $V_{IO}$        | -5           | –    | 5    | mV   | –                                                                                      |
| 5.2.7                    | Overcurrent Warning Threshold Hysteresis                        | $dV_{THOC}$     | 25           |      | –    | mV   | Vs=5.5..8V                                                                             |
| 5.2.8                    | Overcurrent Warning Threshold Hysteresis                        | $dV_{THOC}$     | 50           | 80   | –    | mV   | Vs=8..20V                                                                              |
| 5.2.9                    | Filter Time of Overcurrent Warning                              | $t_{OC}$        | 1.0          | 1.5  | 3.0  | µs   |                                                                                        |
| Short Circuit Protection |                                                                 |                 |              |      |      |      |                                                                                        |
| 5.2.10                   | Filter Time of Short Circuit Protection                         | $t_{SCP(off)}$  | 4.5          | 6.8  | 9    | µs   | default                                                                                |
| 5.2.11                   | Maximum Duty Cycle for no SCD <sup>2)</sup>                     | $D_{ySCDmax}$   | –            | –    | 6    | %    | f <sub>PWM</sub> =20kHz at I <sub>Hx</sub> or I <sub>Lx</sub> and at static applied SC |
| 5.2.12                   | Minimum Duty Cycle for Periodic SCD <sup>2)</sup>               | $D_{ySCDmin}$   | 13           | –    | –    | %    | f <sub>PWM</sub> =20kHz at I <sub>Hx</sub> or I <sub>Lx</sub> and at static applied SC |
| 5.2.13                   | Short Circuit Detection Level SCD1                              | $V_{SCP1(off)}$ | 0.3          | 0.5  | 0.65 | V    | please contact Infineon                                                                |
| 5.2.14                   | Short Circuit Detection Level SCD2                              | $V_{SCP2(off)}$ | 0.6          | 0.75 | 0.9  | V    | –                                                                                      |
| 5.2.15                   | Short Circuit Detection Level SCD3                              | $V_{SCP3(off)}$ | 0.85         | 1.0  | 1.15 | V    | please contact Infineon                                                                |

## Electrical Characteristics - Protection and diagnostic functions (cont'd)

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                          | Symbol          | Limit Values |      |      | Unit | Conditions              |
|--------|------------------------------------|-----------------|--------------|------|------|------|-------------------------|
|        |                                    |                 | Min.         | Typ. | Max. |      |                         |
| 5.2.16 | Short Circuit Detection Level SCD4 | $V_{SCP4(off)}$ | 1.35         | 1.5  | 1.65 | V    | please contact Infineon |
| 5.2.17 | Short Circuit Detection Level SCD5 | $V_{SCP5(off)}$ | 1.8          | 2.0  | 2.2  | V    | –                       |

### ERRx pins

|        |                                          |               |      |   |     |    |                    |
|--------|------------------------------------------|---------------|------|---|-----|----|--------------------|
| 5.2.18 | High Level Output Voltage of ERRx        | $V_{OHERR}$   | 4.0  | – | 5.2 | V  | $I = -0.2mA$       |
| 5.2.19 | Low Level Output Voltage of ERRx         | $V_{OLERR}$   | -0.1 | – | 0.4 | V  | $I = 0.2mA$        |
| 5.2.20 | Propagation Time Difference ERR1 to ERR2 | $t_{PD(ERR)}$ |      | – | 200 | ns | –                  |
| 5.2.21 | Rise Time ERRx (20 - 80 %)               | $t_{r(ERR)}$  | 50   | – | 600 | ns | $C_{LOAD} = 100pF$ |
| 5.2.22 | Fall Time ERRx (80 - 20 %)               | $t_{f(ERR)}$  | 50   | – | 400 | ns | $C_{LOAD} = 100pF$ |

### Over- and undervoltage

|        |                                                  |               |      |     |      |         |                       |
|--------|--------------------------------------------------|---------------|------|-----|------|---------|-----------------------|
| 5.2.23 | Overvoltage Shut Down                            | $V_{OV(off)}$ | 28   | –   | 33   | V       | on $V_S$ and/or $VDH$ |
| 5.2.24 | Overvoltage Filter Time                          | $t_{OV}$      | 30   | –   | 65   | $\mu s$ | –                     |
| 5.2.25 | Undervoltage Shut Down CB1                       | $V_{UV1}$     | 6.75 | –   | 8.25 | V       | CB1 to GND            |
| 5.2.26 | Undervoltage Shut Down CB2                       | $V_{UV2}$     | 3.9  | –   | 5.7  | V       | CB2 to $VDH$          |
| 5.2.27 | Undervoltage Shut Down Hysteresis of CB1 and CB2 | $V_{DUV}$     | –    | 1.0 | –    | V       | –                     |
| 5.2.28 | Undervoltage Filter Time                         | $t_{UV}$      | 1    | –   | 3    | $\mu s$ | –                     |

### Reset and Enable

|        |                                                 |                 |     |   |     |         |   |
|--------|-------------------------------------------------|-----------------|-----|---|-----|---------|---|
| 5.2.29 | Reset Time to clear ERRx Registers              | $t_{Res1}$      | 2.0 | – | –   | $\mu s$ | – |
| 5.2.30 | Low Time of ENAx Signal without Reset           | $t_{Res0}$      | –   | – | 0.5 | $\mu s$ | – |
| 5.2.31 | ENAx Propagation Time (High --> Low)            | $t_{PENA\_H-L}$ | –   | – | 2.0 | $\mu s$ | – |
| 5.2.32 | ENAx Propagation Time (Low --> High)            | $t_{PENA\_L-H}$ | –   | – | 0.5 | $\mu s$ | – |
| 5.2.33 | Return Time to Normal Operation at Auto-Restart | $t_{AR}$        | –   | – | 1.0 | $\mu s$ | – |

1) Not subject to production test; specified by design

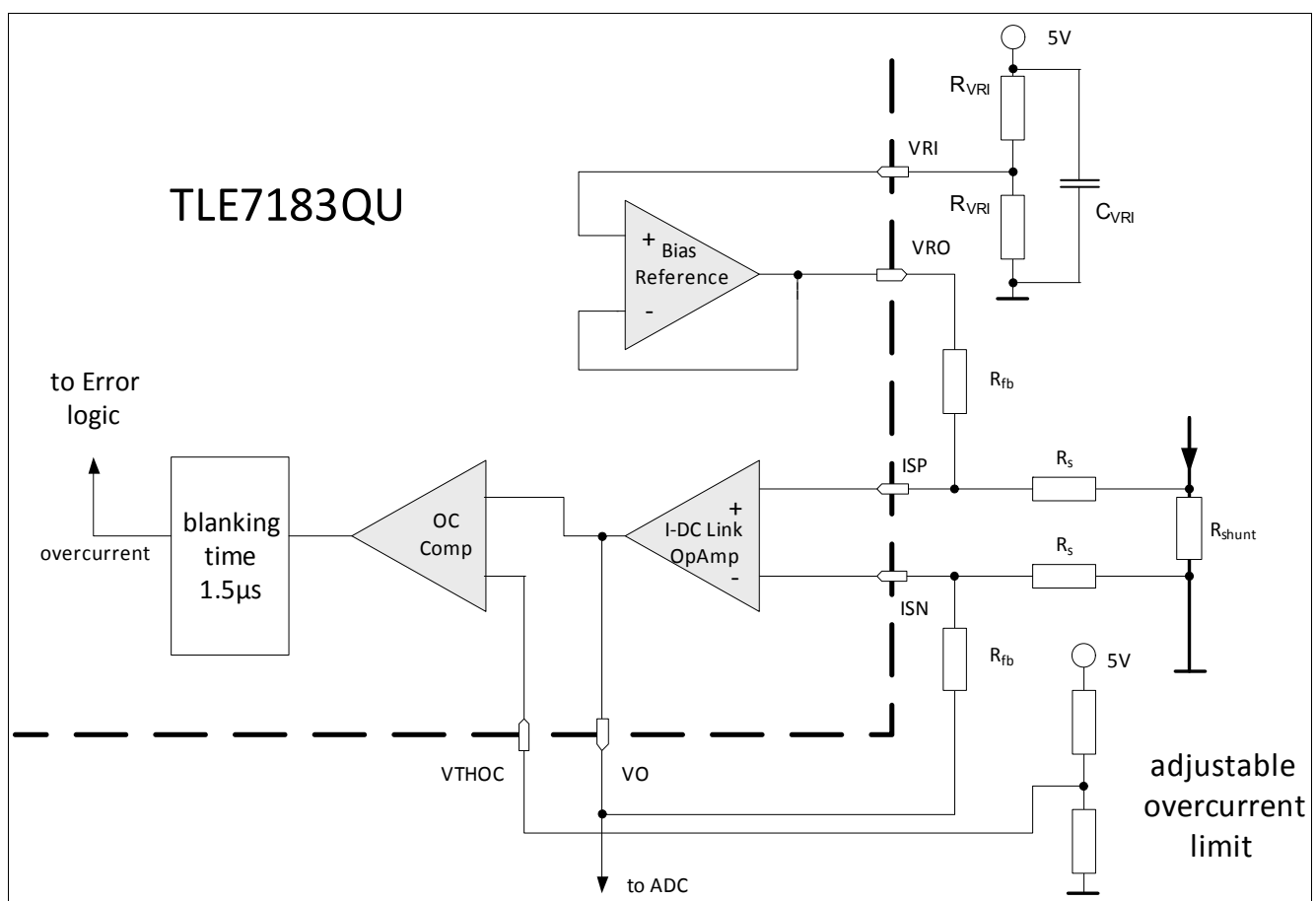
2) Parameters describe the behavior of the internal SCD circuit. Therefore only internal delay times are considered. In application dead-/ delay times determined by application circuit (switching times of MOSFETs, adjusted dead time) have to be considered as well.

### 5.3 Shunt Signal Conditioning

The TLE7183QU incorporates a fast and precise operational amplifier for conditioning and amplification of the current sense shunt signal. A reference bias buffer is integrated to provide an adjustable bias reference for the three OpAmps. The voltage divider connected to the VRI pin should be less than 50 kOhm. If required at all, the filtering capacitor should be less than 1.2  $\mu\text{F}$ . The gain of the OpAmp can be adjusted by external resistors within a range of 5 to 15.

If  $V(\text{ISP})$  equals  $V(\text{ISN})$ , VO provides the reference voltage VRO. Using a voltage divider VRO is usually set to half of the regulated voltage to allow bi-directional current sensing. The additional buffer permits the adaptation of the reference bias to different  $\mu\text{C}$  I/O voltages.

The output of the I-DC link Opamp VO is not short-circuit proof.



**Figure 4 Shunt Signal Conditioning Block Diagram and Overcurrent Limitation**

For overcurrent warning, please see [Chapter 5.2.2](#).

### 5.3.1 Electrical Characteristics

#### Electrical Characteristics - Current sense signal conditioning

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ ,  $f_{PWM} < 25kHz$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                                                                       | Symbol       | Limit Values |              |              | Unit       | Conditions                                                         |
|--------|---------------------------------------------------------------------------------|--------------|--------------|--------------|--------------|------------|--------------------------------------------------------------------|
|        |                                                                                 |              | Min.         | Typ.         | Max.         |            |                                                                    |
| 5.3.1  | Series Resistors                                                                | $R_S$        | 100          | 500          | 1000         | $\Omega$   | –                                                                  |
| 5.3.2  | Feedback Resistor<br>Limited by the Output Voltage<br>Dynamic Range             | $R_{fb}$     | 2000         | 7500         | –            | $\Omega$   | –                                                                  |
| 5.3.3  | Resistor Ratio (Gain Ratio)                                                     | $R_{fb}/R_S$ | 5            | –            | 15           | –          | –                                                                  |
| 5.3.4  | Steady State Differential Input<br>Voltage Range across VIN <sup>1)</sup>       | $V_{IN(ss)}$ | -400         | –            | 400          | mV         | –                                                                  |
| 5.3.5  | Transient Differential Input Voltage<br>Range across VIN                        | $V_{IN(tr)}$ | -800         | –            | 800          | mV         | –                                                                  |
| 5.3.6  | Input Differential Voltage (ISP -<br>ISN)                                       | $V_{IDR}$    | -800         | –            | 800          | mV         | –                                                                  |
| 5.3.7  | Input Voltage (Both Inputs - GND)<br>(ISP - GND) or (ISN -GND)                  | $V_{LL}$     | -800         | –            | 1500         | mV         | $V_S=5.5..8V$                                                      |
| 5.3.8  | Input Voltage (Both Inputs - GND)<br>(ISP - GND) or (ISN -GND)                  | $V_{LL}$     | -800         | –            | 2000         | mV         | $V_S=8..20V$                                                       |
| 5.3.9  | Input Offset Voltage of the I-DC link<br>OpAmp                                  | $V_{IO}$     | –            | 1            | +/-5         | mV         | $R_S=500\Omega$ ; $V_{CM}=0V$ ;<br>$V_O=1.65V$ ;<br>$V_{RI}=1.65V$ |
| 5.3.10 | Input Offset Voltage Temperature<br>Drift of the I-DC link OpAmp <sup>2)</sup>  | $V_{IO}$     | –            | 1            | 2            | mV         | $R_S=500\Omega$ ; $V_{CM}=0V$ ;<br>$V_O=1.65V$ ;<br>$V_{RI}=1.65V$ |
| 5.3.11 | Input Offset Voltage of the<br>Reference Buffer                                 | $V_{IO}$     |              | 1            | +/-5         | mV         | –                                                                  |
| 5.3.12 | Input Offset Voltage Temperature<br>Drift of the Reference Buffer <sup>2)</sup> | $V_{IO}$     |              | 1            | 2            | mV         | –                                                                  |
| 5.3.13 | Input Range at VRI                                                              | $V_{IO}$     | 1.2          | –            | 2.8          | V          | –                                                                  |
| 5.3.14 | Input Bias Current (ISx to GND)                                                 | $I_{IB}$     | -300         | –            | –            | $\mu A$    | $V_{CM}=0V$ ; $V_O=open$                                           |
| 5.3.15 | High Level Output Voltage of VO                                                 | $V_{OH}$     | 4.8          | –            | 5.2          | V          | $V_{RI}=1.65V/2.5V$ ;<br>$I_{OH}=-3mA$                             |
| 5.3.16 | Low Level Output Voltage of VO                                                  | $V_{OL}$     | -0.1         | –            | 0.2          | V          | $V_{RI}=1.65V/2.5V$ ;<br>$I_{OH}=3mA$                              |
| 5.3.17 | Output Voltage of VO <sup>3)</sup><br>$V_{RI}=2.5V$ ,<br>$V_{RI}=1.65V$         | $V_{OR}$     | 2.42<br>1.58 | 2.50<br>1.65 | 2.58<br>1.73 | V          | $V_{IN(ss)}=0V$ ;<br>Gain=15;                                      |
| 5.3.18 | Temperature Drift of Output<br>Voltage of VO <sup>3)</sup>                      | $V_O$        | 0            | –            | 32           | mV         | $V_{IN(ss)}=0V$ ;<br>Gain=15                                       |
| 5.3.19 | Guaranteed Output Current<br>Capability                                         | $I_{GOC}$    | -5           | –            | 5            | mA         | –                                                                  |
| 5.3.20 | Differential Input Resistance <sup>2)</sup>                                     | $R_I$        | 100          | –            | –            | k $\Omega$ | –                                                                  |
| 5.3.21 | Common Mode Input capacitance <sup>2)</sup>                                     | $C_{CM}$     | –            | –            | 10           | pF         | 10kHz                                                              |

### Electrical Characteristics - Current sense signal conditioning (cont'd)

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ ,  $f_{PWM} < 25kHz$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.   | Parameter                                                                                                                                   | Symbol            | Limit Values |                |      | Unit | Conditions                                                                                        |
|--------|---------------------------------------------------------------------------------------------------------------------------------------------|-------------------|--------------|----------------|------|------|---------------------------------------------------------------------------------------------------|
|        |                                                                                                                                             |                   | Min.         | Typ.           | Max. |      |                                                                                                   |
| 5.3.22 | Common Mode Rejection Ratio at DC<br>CMRR =<br>$20 \cdot \log((V_{out\_diff}/V_{in\_diff}) \cdot (V_{in\_CM}/V_{out\_CM}))$                 | CMRR              | 80           | 100            | –    | db   | –                                                                                                 |
| 5.3.23 | Common Mode Suppression <sup>4)</sup> with<br>CMS = $20 \cdot \log(V_{out\_CM}/V_{in\_CM})$<br>Freq = 100kHz<br>Freq = 1MHz<br>Freq = 10MHz | CMS               | –            | 62<br>43<br>33 | –    | db   | VIN=360mV*<br>$\sin(2 \cdot \pi \cdot freq \cdot t)$ ;<br>Rs=500Ω;<br>Rfb=7500Ω;<br>VRI=1.65/2.5V |
| 5.3.24 | Slew Rate                                                                                                                                   | $dV/dt$           | 3            | 10             | –    | V/μs | Gain ≥ 5;<br>RL=1.0kΩ;<br>CL=500pF                                                                |
| 5.3.25 | Large Signal Open Loop Voltage Gain (DC)                                                                                                    | $A_{OL}$          | 80           | 100            | –    | dB   | –                                                                                                 |
| 5.3.26 | Unity Gain Bandwidth                                                                                                                        | GBW               | 10           | 20             | –    | MHz  | RL=1kΩ; CL=100pF                                                                                  |
| 5.3.27 | Phase Margin <sup>2)</sup>                                                                                                                  | $\phi_M$          | –            | 50             | –    | °    | Gain ≥ 5;<br>RL=1kΩ; CL=100pF                                                                     |
| 5.3.28 | Gain Margin <sup>2)</sup>                                                                                                                   | $A_M$             | –            | 12             | –    | db   | RL=1kΩ; CL=100pF                                                                                  |
| 5.3.29 | Bandwidth                                                                                                                                   | BWG               | 1.6          | –              | –    | MHz  | Gain=15;<br>RL=1kΩ;<br>CL=500pF;<br>Rs=500Ω                                                       |
| 5.3.30 | Output Settle Time to 98% <sup>1)</sup>                                                                                                     | t <sub>set</sub>  | –            | 1              | 1.8  | μs   | Gain=15;<br>RL=1kΩ;<br>CL=500pF;<br>0.3<VO< 4.8V;<br>Rs=500Ω                                      |
| 5.3.31 | Output Rise Time 10% to 90% <sup>1)</sup>                                                                                                   | t <sub>rise</sub> | –            | –              | 1    | μs   | Gain=15;<br>RL=1kΩ; CL=500pF;<br>0.3<VO< 4.8V;<br>Rs=500Ω                                         |
| 5.3.32 | Output Fall Time 90% to 10% <sup>1)</sup>                                                                                                   | t <sub>fall</sub> | –            | –              | 1    | μs   | Gain=15;<br>RL=1kΩ; CL=500pF;<br>0.3<VO< 4.8V;<br>Rs=500Ω;                                        |

1) Input current and output amplifier characteristics:

"Output signal must be amplified and available at 2μs after input signal change (Gain 5...15)

2) Not subject to production test; specified by design

3) calculated out of [5.3.9](#), [5.3.10](#), [5.3.11](#) and [5.3.12](#)

4) Without considering any offsets such as input offset voltage, internal mismatch and assuming no tolerance error in external resistors.

## 5.4 Phase Voltage Feedback

The TLE7183QU incorporates a fast conversion of the phase voltages to logic signals. The threshold values are proportional to  $V_{DH}$ . The outputs are 5V push pull stages. If they are not used they can be left open.

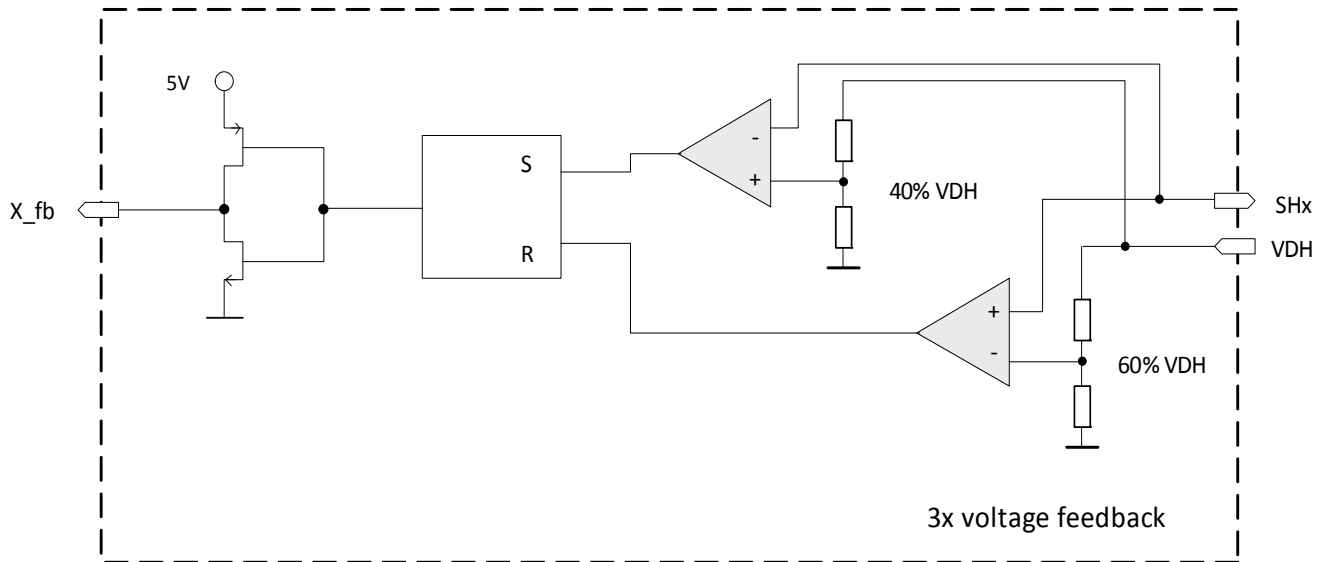


Figure 5 Block Diagram Phase Voltage Feedback

### 5.4.1 Electrical Characteristics

#### Electrical Characteristics - Phase Voltage Feedback

$V_S = 5.5$  to  $20V$ ,  $T_j = -40$  to  $+150^\circ C$ ,  $f_{PWM} < 25kHz$ , all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Pos.  | Parameter                                      | Symbol      | Limit Values |      |      | Unit          | Conditions                              |
|-------|------------------------------------------------|-------------|--------------|------|------|---------------|-----------------------------------------|
|       |                                                |             | Min.         | Typ. | Max. |               |                                         |
| 5.4.1 | Low Level Threshold                            | $V_{ILfb}$  | 35           | 40   | 45   | % of $V_{DH}$ | $V_{DH} > 5.5V$<br>$V_{SHX}$ decreasing |
| 5.4.2 | High Level Threshold                           | $V_{IHfb}$  | 55           | 60   | 65   | % of $V_{DH}$ | $V_{DH} > 5.5V$<br>$V_{SHX}$ decreasing |
| 5.4.3 | High Level Output Voltage of $X_{fb}$          | $V_{OHfb}$  | 4.0          | —    | 5.2  | V             | $I = -0.5mA$                            |
| 5.4.4 | Low Level Output Voltage of $X_{fb}$           | $V_{OLfb}$  | -0.1         | —    | 0.2  | V             | $I = 0.5mA$                             |
| 5.4.5 | Propagation Delay Time incl. Rise or Fall Time | $t_{PDfb}$  | —            | —    | 110  | ns            | $C_{LOAD} < 100pF$                      |
| 5.4.6 | Matching of Propagation Delay Time             | $t_{dPDfb}$ | —            | —    | 30   | ns            |                                         |



## 6.1 Layout Guide Lines

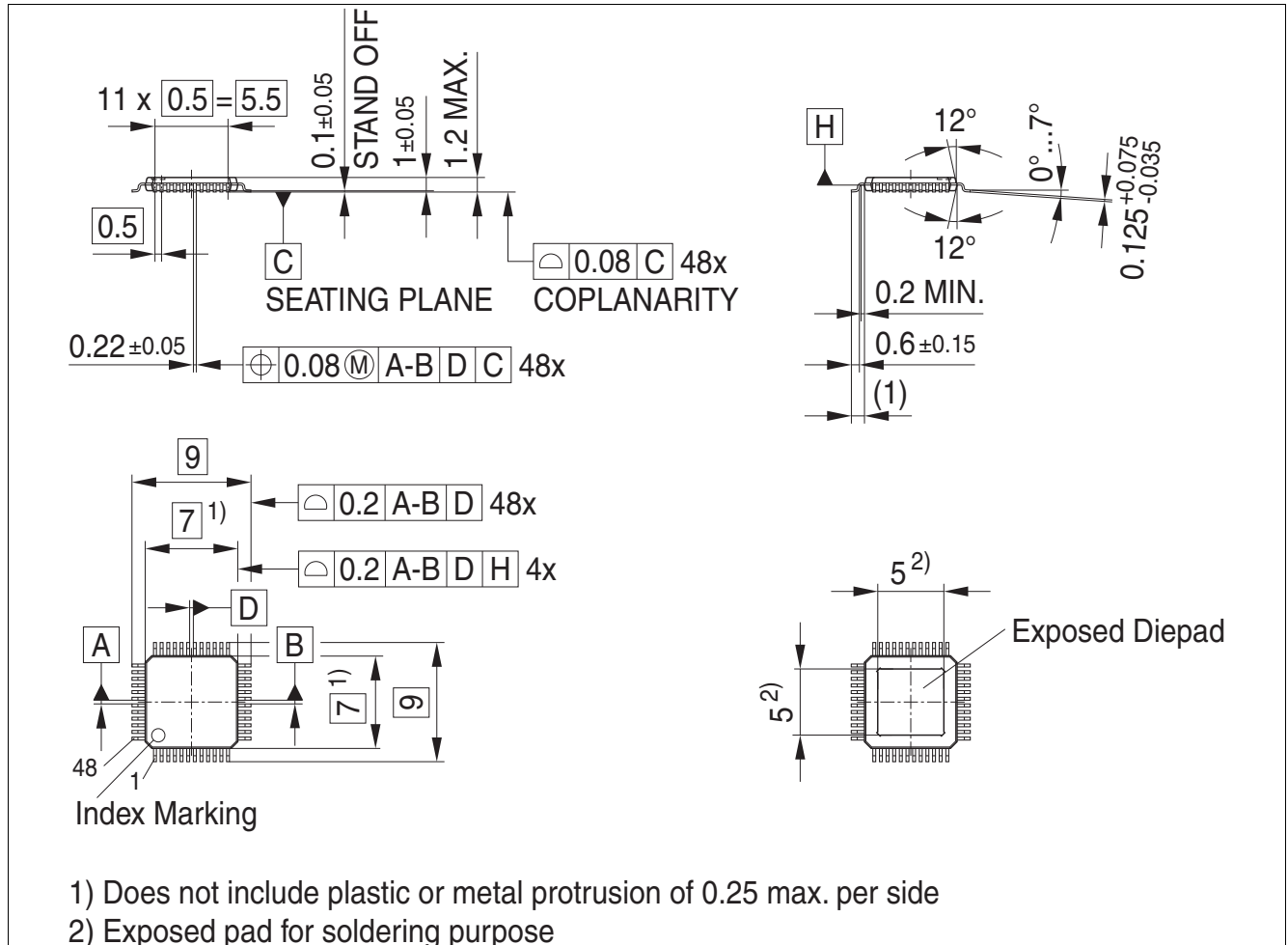
Please refer also to the simplified application example.

- Three separate bulk capacitors  $C_B$  should be used - one per half bridge
- Three separate ceramic capacitors  $C_C$  should be used - one per half bridge
- Each of the 3 bulk capacitors  $C_B$  and each of the 3 ceramic capacitors  $C_C$  should be assigned to one of the half bridges and should be placed very close to it
- The components within one half bridge should be placed close to each other: high side MOSFET, low side MOSFET, bulk capacitor  $C_B$  and ceramic capacitor  $C_C$  ( $C_B$  and  $C_C$  are in parallel) and the shunt resistor form a loop that should be as small and tight as possible. The traces should be short and wide
- The three half bridges can be separated but if there is one common GND referenced shunt resistor for the three half bridges the sources of the three low side MOSFETs should be close to each other and close to the common shunt resistor
- VDH is the sense pin used for short circuit detection; VDH should be routed (via Rvdh) to the common point of the drains of the high side MOSFETs to sense the voltage of the drain high side
- CB2 is the buffer capacitor of charge pump 2; its negative terminal should be routed to the common point of the drains of the high side MOSFETs as well - this connection should be low inductive / resistive
- Additional R-C snubber circuits (R and C in series) can be placed to attenuate/suppress oscillations during switching of the MOSFETs, there may be one or two snubber circuits per half bridge, R (several Ohm) and C (several nF) must be low inductive in terms of routing and packaging (ceramic capacitors)
- the exposed pad on the backside of the package should be connected to GND

## 6.2 Further Application Information

- For further information you may contact <http://www.infineon.com/>

## 7 Package Outlines



**Figure 7 PG-TQFP-48**

### Green Product

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e. Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

## 8 Revision History

| Version | Date       | Changes                                                                                |
|---------|------------|----------------------------------------------------------------------------------------|
| 1.1     | 2016-01-28 | - package adjustments<br>- replaced misleading term $\overline{\text{ERRx}}$ with ERRx |
| 1.0     | 2011-09-09 | Data Sheet                                                                             |

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